

# DS34C87T CMOS Quad TRI-STATE Differential Line Driver

Check for Samples: DS34C87T

#### **FEATURES**

- TTL Input Compatible
- Typical Propagation Delays: 6 ns
- Typical Output Skew: 0.5 ns
- Outputs Won't Load Line When  $V_{CC} = 0V$
- Meets the Requirements of EIA Standard RS-
- **Operation from Single 5V Supply**
- **TRI-STATE Outputs for Connection to System**
- **Low Quiescent Current**
- Available in Surface Mount

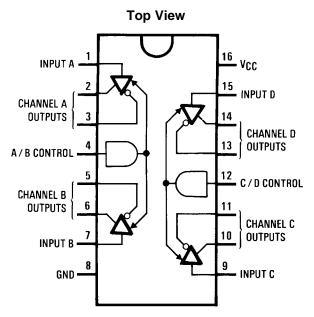
#### DESCRIPTION

The DS34C87T is a guad differential line driver designed for digital data transmission over balanced lines. The DS34C87T meets all the requirements of EIA standard RS-422 while retaining the low power characteristics of CMOS. This enables construction of serial and terminal interfaces while maintaining minimal power consumption.

The DS34C87T accepts TTL or CMOS input levels and translates these to RS-422 output levels. This part uses special output circuitry that enables the individual drivers to power down without loading down the bus. This device has separate enable circuitry for each pair of the four drivers. The DS34C87T is pin compatible to the DS3487T.

All inputs are protected against damage due to electrostatic discharge by diodes to V<sub>CC</sub> and ground.

### **Connection and Logic Diagrams**



See PIN DESCRIPTIONS for details.

Figure 1. PDIP Package See Package Numbers D0016A or NFG0016E

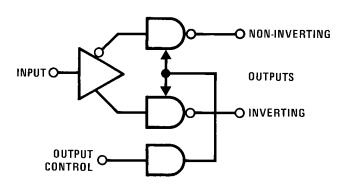


Figure 2. Logic Diagram

Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet. All trademarks are the property of their respective owners.



# Truth Table<sup>(1)</sup>

Input	Control	Non-Inverting	Inverting
	Input	Output	Output
Н	Н	Н	L
L	Н	L	Н
X	L	Z	Z

(1) L = Low logic state

H = High logic state

X = Irrelevant

Z = TRI-STATE (high performance)



These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

# Absolute Maximum Ratings (1)(2)(3)(4)

−0.5 to 7.0V
-1.5 to V <sub>CC</sub> +1.5V
-0.5 to 7V
±20 mA
±150 mA
±150 mA
−65°C to +150°C
•
1736 mW
1226 mW
260°C

- (1) Unless otherwise specified, all voltages are referenced to ground. All currents into device pins are positive; all currents out of device pins are negative.
- (2) Absolute Maximum Ratings are those values beyond which the safety of the device cannot be specified. They are not meant to imply that the device should be operated at these limits. The table of "Electrical Characteristics" provide conditions for actual device operation.
- (3) ESD Rating: HBM (1.5 kΩ, 100 pF) Inputs ≥ 1500V Outputs ≥ 1000V EIAJ (0Ω, 200 pF) All Pins ≥ 350V
- (4) If Military/Aerospace specified devices are required, please contact the Texas Instruments Sales Office/ Distributors for availability and specifications.
- (5) Ratings apply to ambient temperature at 25°C. Above this temperature derate NFG0016E Package 13.89 mW/°C, and D0016A Package 9.80 mW/°C.
- (6) ESD Rating: HBM (1.5 k $\Omega$ , 100 pF) Inputs ≥ 1500V Outputs ≥ 1000V EIAJ (0 $\Omega$ , 200 pF) All Pins ≥ 350V

### **Operating Conditions**

	Min	Max	Units
Supply Voltage (V <sub>CC</sub> )	4.50	5.50	٧
DC Input or Output Voltage (V <sub>IN</sub> , V <sub>OUT</sub> )	0	V <sub>CC</sub>	V
Operating Temperature Range (T <sub>A</sub> ) DS34C87T	-40	+85	°C
Input Rise or Fall Times (t <sub>r</sub> , t <sub>f</sub> )		500	ns



### DC Electrical Characteristics(1)

 $V_{CC} = 5V \pm 10\%$  (unless otherwise specified)

	Parameter	Test Conditions	Min	Тур	Max	Units
V <sub>IH</sub> High Level Input			2.0			V
	Voltage					
V <sub>IL</sub>	Low Level Input				0.8	V
	Voltage					
V <sub>OH</sub>	High Level Output	$V_{IN} = V_{IH}$ or $V_{IL}$ ,	2.5	3.4		V
	Voltage	I <sub>OUT</sub> = −20 mA				
$V_{OL}$	Low Level Output	$V_{IN} = V_{IH}$ or $V_{IL}$ ,		0.3	0.5	V
	Voltage	I <sub>OUT</sub> = 48 mA				
V <sub>T</sub>	Differential Output	R <sub>L</sub> = 100 Ω	2.0	3.1		V
	Voltage	See <sup>(2)</sup>				
$ V_T - \overline{V}_T $	Difference In	R <sub>L</sub> = 100 Ω			0.4	V
	Differential Output	See <sup>(2)</sup>				
Vos	Common Mode	R <sub>L</sub> = 100 Ω		2.0	3.0	V
	Output Voltage	See <sup>(2)</sup>				
$ V_{OS} - \overline{V}_{OS} $	Difference In	$R_L = 100 \Omega$			0.4	V
	Common Mode Output	See <sup>(2)</sup>				
I <sub>IN</sub>	Input Current	$V_{IN} = V_{CC}$ , GND, $V_{IH}$ , or $V_{IL}$			±1.0	μΑ
Icc	Quiescent Supply	I <sub>OUT</sub> = 0 μA,				
	Current	$V_{IN} = V_{CC}$ or GND		200	500	μΑ
		$V_{IN} = 2.4V \text{ or } 0.5V^{(3)}$		8.0	2.0	mA
l <sub>OZ</sub>	TRI-STATE Output	V <sub>OUT</sub> = V <sub>CC</sub> or GND		±0.5	±5.0	μΑ
	Leakage Current	Control = V <sub>IL</sub>				
I <sub>SC</sub>	Output Short	V <sub>IN</sub> = V <sub>CC</sub> or GND	-30		-150	mA
	Circuit Current	See <sup>(2)</sup> and <sup>(4)</sup>				
I <sub>OFF</sub>	Power Off Output	V <sub>CC</sub> = 0V V <sub>OUT</sub> = 6V			100	μA
	Leakage Current	See <sup>(2)</sup> $V_{OUT} = -0.25V$			-100	μA
		+				

<sup>(1)</sup> Unless otherwise specified, min/max limits apply across the  $-40^{\circ}$ C to  $85^{\circ}$ C temperature range. All typicals are given for  $V_{CC} = 5V$  and  $T_{A} = 25^{\circ}$ C.

See EIA Specification RS-422 for exact test conditions.

Measured per input. All other inputs at V<sub>CC</sub> or GND.

This is the current sourced when a high output is shorted to ground. Only one output at a time should be shorted.



## Switching Characteristics(1)

 $V_{CC} = 5V \pm 10\%$ , t<sub>r</sub>, t<sub>f</sub>  $\leq$  6 ns (Figure 3, Figure 4, Figure 5, Figure 6)

	Parameter	Test Conditions	Min	Тур	Max	Units
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay Input to Output	S1 Open		6	11	ns
Skew	See <sup>(2)</sup>	S1 Open		0.5	3	ns
t <sub>TLH</sub> , t <sub>THL</sub>	Differential Output Rise And Fall Times	S1 Open		6	10	ns
t <sub>PZH</sub>	Output Enable Time	S1 Closed		12	25	ns
t <sub>PZL</sub>	Output Enable Time	S1 Closed		13	26	ns
t <sub>PHZ</sub>	Output Disable Time (3)	S1 Closed		4	8	ns
t <sub>PLZ</sub>	Output Disable Time (3)	S1 Closed		6	12	ns
C <sub>PD</sub>	Power Dissipation Capacitance <sup>(4)</sup>			100		pF
C <sub>IN</sub>	Input Capacitance			6		pF

- (1) Unless otherwise specified, min/max limits apply across the  $-40^{\circ}$ C to 85°C temperature range. All typicals are given for  $V_{CC} = 5V$  and  $T_{A} = 25^{\circ}$ C.
- (2) Skew is defined as the difference in propagation delays between complementary outputs at the 50% point.
- (3) Output disable time is the delay from the control input being switched to the output transistors turning off. The actual disable times are less than indicated due to the delay added by the RC time constant of the load.
- (4) C<sub>PD</sub> determines the no load dynamic power consumption, P<sub>D</sub> = C<sub>PD</sub> V<sup>2</sup>CC f + I<sub>CC</sub> V<sub>CC</sub>, and the no load dynamic current consumption, I<sub>S</sub> = C<sub>PD</sub> V<sub>CC</sub> f + I<sub>CC</sub>.

# Comparison Table of Switching Characteristics into "LS-Type" Load (1)

 $V_{CC}$  = 5V,  $T_A$  = +25°C,  $t_r \le 6$  ns,  $t_f \le 6$  ns (Figure 6, Figure 7, Figure 8, Figure 9, Figure 10, Figure 11)

	Barranatan	Total Completions	DS3	4C87	DS	3487	1111	
Parameter		Test Conditions	Тур	Max	Тур	Max	Units	
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay		6	10	10	15	ns	
	Input to Output							
Skew	See <sup>(2)</sup>		1.5	2.0			ns	
t <sub>THL</sub> , t <sub>TLH</sub>	Differential Output Rise		4	7	10	15	ns	
	and Fall Times							
t <sub>PHZ</sub>	Output Disable Time	$C_L = 50 \text{ pF}, R_L = 200\Omega,$	8	11	17	25	ns	
	See <sup>(3)</sup>	S1 Closed, S2 Closed						
t <sub>PLZ</sub>	Output Disable Time	$C_L = 50 \text{ pF}, R_L = 200\Omega,$	7	10	15	25	ns	
	See <sup>(3)</sup>	S1 Closed, S2 Closed						
t <sub>PZH</sub>	Output Enable Time	$C_L = 50 \text{ pF}, R_L = \infty,$	11	19	11	25	ns	
		S1 Open, S2 Closed						
t <sub>PZL</sub>	Output Enable Time	$C_L = 50 \text{ pF}, R_L = 200\Omega,$	14	21	15	25	ns	
		S1 Closed, S2 Open						

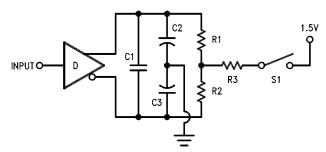
<sup>(1)</sup> This table is provided for comparison purposes only. The values in this table for the DS34C87 reflect the performance of the device but are not tested or ensured.

<sup>(2)</sup> Skew is defined as the difference in propagation delays between complementary outputs at the 50% point.

<sup>(3)</sup> Output disable time is the delay from the control input being switched to the output transistors turning off. The actual disable times are less than indicated due to the delay added by the RC time constant of the load.



#### AC TEST CIRCUIT AND SWITCHING TIME WAVEFORMS



**Note:** C1 = C2 = C3 = 40 pF (including Probe and Jig Capacitance), R1 = R2 =  $50\Omega$ , R3 =  $500\Omega$ 

Figure 3. AC Test Circuit

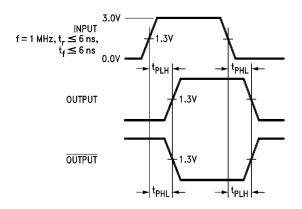


Figure 4. Propagation Delays

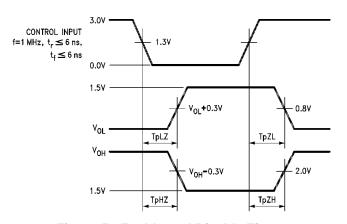


Figure 5. Enable and Disable Times

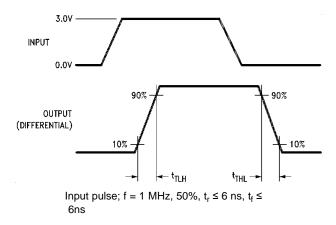


Figure 6. Differential Rise and Fall Times

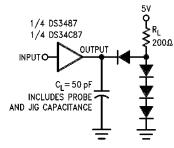


Figure 7. Propagation Delays Test Circuit for "LS-Type" Load



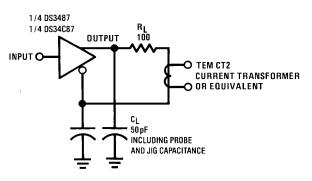


Figure 8. Differential Rise and Fall Times Test Circuit for "LS-Type" Load

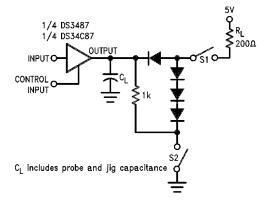


Figure 9. Load Enable and Disable Times Test Circuit for "LS-Type" Load

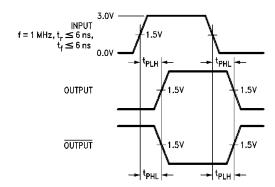


Figure 10. Load Propagation Delays for "LS-Type" Load

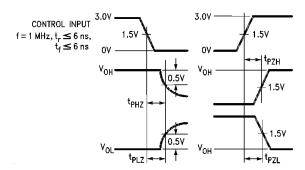
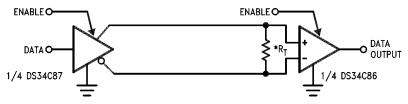


Figure 11. Load Enable and Disable Times for "LS-Type" Load

#### TYPICAL APPLICATIONS



\*R<sub>T</sub> is optional although highly recommended to reduce reflection.

Submit Documentation Feedback



### **PIN DESCRIPTIONS**

		PIN DESCRIPTIONS	
Pin Number (PDIP or SOIC package)	Pin Name	Function	
1	INPUT A	Channel A - TTL/CMOS input	
2	OUTPUT A - True	True Output for Channel A, RS422 Levels	
3	OUTPUT A - Inverting	Inverting Output for Channel A, RS422 Levels	
4	A/B CONTROL	Enable Pin for Channels A and B, Active High, TTL/CMOS Levels	
5	OUTPUT B - Inverting	Inverting Output for Channel B, RS422 Levels	
6	OUTPUT B - True	True Output for Channel B, RS422 Levels	
7	INPUT B	Channel B - TTL/CMOS input	
8	GND	Ground Pin (0 V)	
9	INPUT C	Channel C - TTL/CMOS input	
10	OUTPUT C - True	True Output for Channel C, RS422 Levels	
11	OUTPUT C - Inverting	Inverting Output for Channel C, RS422 Levels	
12	C/D CONTROL	Enable Pin for Channels C and D, Active High, TTL/CMOS Levels	
13	OUTPUT D - Inverting	Inverting Output for Channel D, RS422 Levels	
14	OUTPUT D - True	True Output for Channel D, RS422 Levels	
15	INPUT D	Channel D - TTL/CMOS input	
16	V <sub>CC</sub>	Power Supply Pin, 5.0V typical	

### SNLS376B -MAY 1998-REVISED APRIL 2013



# **REVISION HISTORY**

Cł	nanges from Revision A (April 2013) to Revision B	Page
•	Changed layout of National Data Sheet to TI format	7



# PACKAGE OPTION ADDENDUM

23-Aug-2017

#### PACKAGING INFORMATION

www.ti.com

Orderable Device	Status	Package Type	_	Pins	Package	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Device Marking	Samples
	(1)		Drawing		Qty	(2)	(6)	(3)		(4/5)	
DS34C87TM	LIFEBUY	SOIC	D	16	48	TBD	Call TI	Call TI	-40 to 85	DS34C87TM	
DS34C87TM/NOPB	ACTIVE	SOIC	D	16	48	Green (RoHS & no Sb/Br)	CU SN   Call TI	Level-1-260C-UNLIM	-40 to 85	DS34C87TM	Samples
DS34C87TMX	LIFEBUY	SOIC	D	16	2500	TBD	Call TI	Call TI	-40 to 85	DS34C87TM	
DS34C87TMX/NOPB	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU SN	Level-1-260C-UNLIM	-40 to 85	DS34C87TM	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.



# **PACKAGE OPTION ADDENDUM**

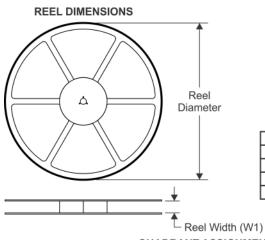
23-Aug-2017

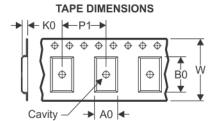
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PACKAGE MATERIALS INFORMATION

www.ti.com 10-Aug-2018

# TAPE AND REEL INFORMATION





		Dimension designed to accommodate the component width
ı		Dimension designed to accommodate the component length
ı	K0	Dimension designed to accommodate the component thickness
ı	W	Overall width of the carrier tape
-	P1	Pitch between successive cavity centers

# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DS34C87TMX/NOPB	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.3	8.0	16.0	Q1

www.ti.com 10-Aug-2018

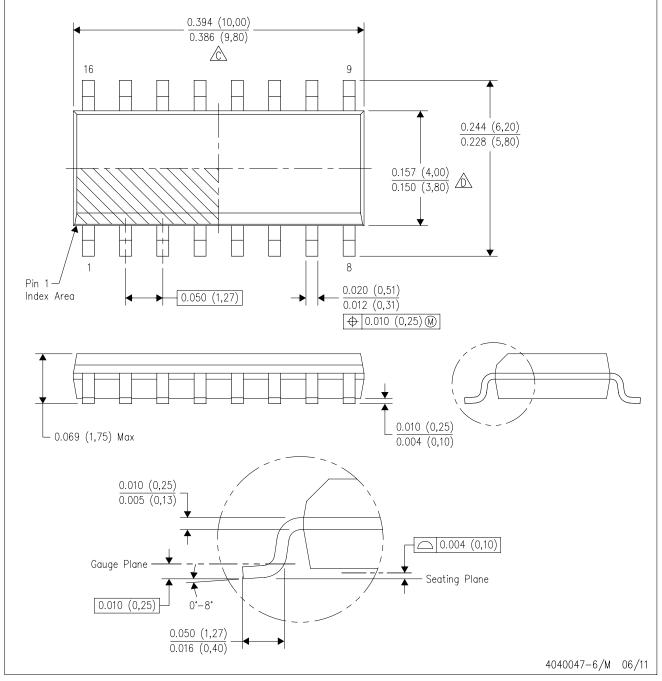


#### \*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
DS34C87TMX/NOPB	SOIC	D	16	2500	367.0	367.0	35.0

# D (R-PDS0-G16)

# PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.006 (0,15) each side.
- Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
- E. Reference JEDEC MS-012 variation AC.



#### **IMPORTANT NOTICE**

Texas Instruments Incorporated (TI) reserves the right to make corrections, enhancements, improvements and other changes to its semiconductor products and services per JESD46, latest issue, and to discontinue any product or service per JESD48, latest issue. Buyers should obtain the latest relevant information before placing orders and should verify that such information is current and complete.

TI's published terms of sale for semiconductor products (http://www.ti.com/sc/docs/stdterms.htm) apply to the sale of packaged integrated circuit products that TI has qualified and released to market. Additional terms may apply to the use or sale of other types of TI products and services.

Reproduction of significant portions of TI information in TI data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. TI is not responsible or liable for such reproduced documentation. Information of third parties may be subject to additional restrictions. Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Buyers and others who are developing systems that incorporate TI products (collectively, "Designers") understand and agree that Designers remain responsible for using their independent analysis, evaluation and judgment in designing their applications and that Designers have full and exclusive responsibility to assure the safety of Designers' applications and compliance of their applications (and of all TI products used in or for Designers' applications) with all applicable regulations, laws and other applicable requirements. Designer represents that, with respect to their applications, Designer has all the necessary expertise to create and implement safeguards that (1) anticipate dangerous consequences of failures, (2) monitor failures and their consequences, and (3) lessen the likelihood of failures that might cause harm and take appropriate actions. Designer agrees that prior to using or distributing any applications that include TI products, Designer will thoroughly test such applications and the functionality of such TI products as used in such applications.

TI's provision of technical, application or other design advice, quality characterization, reliability data or other services or information, including, but not limited to, reference designs and materials relating to evaluation modules, (collectively, "TI Resources") are intended to assist designers who are developing applications that incorporate TI products; by downloading, accessing or using TI Resources in any way, Designer (individually or, if Designer is acting on behalf of a company, Designer's company) agrees to use any particular TI Resource solely for this purpose and subject to the terms of this Notice.

TI's provision of TI Resources does not expand or otherwise alter TI's applicable published warranties or warranty disclaimers for TI products, and no additional obligations or liabilities arise from TI providing such TI Resources. TI reserves the right to make corrections, enhancements, improvements and other changes to its TI Resources. TI has not conducted any testing other than that specifically described in the published documentation for a particular TI Resource.

Designer is authorized to use, copy and modify any individual TI Resource only in connection with the development of applications that include the TI product(s) identified in such TI Resource. NO OTHER LICENSE, EXPRESS OR IMPLIED, BY ESTOPPEL OR OTHERWISE TO ANY OTHER TI INTELLECTUAL PROPERTY RIGHT, AND NO LICENSE TO ANY TECHNOLOGY OR INTELLECTUAL PROPERTY RIGHT OF TI OR ANY THIRD PARTY IS GRANTED HEREIN, including but not limited to any patent right, copyright, mask work right, or other intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information regarding or referencing third-party products or services does not constitute a license to use such products or services, or a warranty or endorsement thereof. Use of TI Resources may require a license from a third party under the patents or other intellectual property of TI.

TI RESOURCES ARE PROVIDED "AS IS" AND WITH ALL FAULTS. TI DISCLAIMS ALL OTHER WARRANTIES OR REPRESENTATIONS, EXPRESS OR IMPLIED, REGARDING RESOURCES OR USE THEREOF, INCLUDING BUT NOT LIMITED TO ACCURACY OR COMPLETENESS, TITLE, ANY EPIDEMIC FAILURE WARRANTY AND ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, AND NON-INFRINGEMENT OF ANY THIRD PARTY INTELLECTUAL PROPERTY RIGHTS. TI SHALL NOT BE LIABLE FOR AND SHALL NOT DEFEND OR INDEMNIFY DESIGNER AGAINST ANY CLAIM, INCLUDING BUT NOT LIMITED TO ANY INFRINGEMENT CLAIM THAT RELATES TO OR IS BASED ON ANY COMBINATION OF PRODUCTS EVEN IF DESCRIBED IN TI RESOURCES OR OTHERWISE. IN NO EVENT SHALL TI BE LIABLE FOR ANY ACTUAL, DIRECT, SPECIAL, COLLATERAL, INDIRECT, PUNITIVE, INCIDENTAL, CONSEQUENTIAL OR EXEMPLARY DAMAGES IN CONNECTION WITH OR ARISING OUT OF TI RESOURCES OR USE THEREOF, AND REGARDLESS OF WHETHER TI HAS BEEN ADVISED OF THE POSSIBILITY OF SUCH DAMAGES.

Unless TI has explicitly designated an individual product as meeting the requirements of a particular industry standard (e.g., ISO/TS 16949 and ISO 26262), TI is not responsible for any failure to meet such industry standard requirements.

Where TI specifically promotes products as facilitating functional safety or as compliant with industry functional safety standards, such products are intended to help enable customers to design and create their own applications that meet applicable functional safety standards and requirements. Using products in an application does not by itself establish any safety features in the application. Designers must ensure compliance with safety-related requirements and standards applicable to their applications. Designer may not use any TI products in life-critical medical equipment unless authorized officers of the parties have executed a special contract specifically governing such use. Life-critical medical equipment is medical equipment where failure of such equipment would cause serious bodily injury or death (e.g., life support, pacemakers, defibrillators, heart pumps, neurostimulators, and implantables). Such equipment includes, without limitation, all medical devices identified by the U.S. Food and Drug Administration as Class III devices and equivalent classifications outside the U.S.

TI may expressly designate certain products as completing a particular qualification (e.g., Q100, Military Grade, or Enhanced Product). Designers agree that it has the necessary expertise to select the product with the appropriate qualification designation for their applications and that proper product selection is at Designers' own risk. Designers are solely responsible for compliance with all legal and regulatory requirements in connection with such selection.

Designer will fully indemnify TI and its representatives against any damages, costs, losses, and/or liabilities arising out of Designer's non-compliance with the terms and provisions of this Notice.